



## **CE EMC**

### **TEST REPORT**

**For**

**Analogue Output Control Card**

**Model: MIC-3723R**

**Trade Name: ADVANTECH**

Issued to

**Advantech Co., Ltd.**

**No. 1, Alley 20, Lane 26, Rueiguang Road,  
Neihu District, Taipei 114, R.O.C.**

Issued by



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# 1 TEST RESULT CERTIFICATION

**Applicant:** Advantech Co., Ltd.  
No. 1, Alley 20, Lane 26, Rueiguang Road,  
Neihu District, Taipei 114, R.O.C.

**Manufacturer:** Advantech Co., Ltd.  
No. 1, Alley 20, Lane 26, Rueiguang Road,  
Neihu District, Taipei 114, R.O.C.

**Equipment Under Test:** Analogue Output Control Card

**Trade Name:** ADVANTECH

**Model:** MIC-3723R

**Detailed EUT Description:** See Item 2 of this report

**Date of Test:** July 26, 2006 ~ August 23, 2006

Applicable Standard	Class/Limit/Criterion	Test Result
EN 55011: 1998 + A1: 1999 + A2: 2002	Group 1 / Class A	No non-compliance noted
EN 55022: 1998 + A1: 2000 + A2: 2003	Class A	No non-compliance noted
EN 61000-3-2: 2000	Class D	No non-compliance noted
EN 61000-3-3: 1995 + A1: 2001	Limit	No non-compliance noted
EN 61000-6-2: 2001 (EN 55024: 1998 + A1: 2001 + A2: 2003), including		
IEC 61000-4-2: 1995 + A1: 1998 + A2: 2000	Criterion B	No non-compliance noted
IEC 61000-4-3: 2002 + A1: 2002	Criterion A	No non-compliance noted
IEC 61000-4-4: 1995 + A1: 2000 + A2: 2001	Criterion B	No non-compliance noted
IEC 61000-4-5: 1995 + A1: 2000	Criterion B	No non-compliance noted
IEC 61000-4-6: 1996 + A1: 2000	Criterion A	No non-compliance noted
IEC 61000-4-8: 1993 + A1: 2000	Criterion A	No non-compliance noted
IEC 61000-4-11: 1994 + A1: 2000	Criterion B/C/C	No non-compliance noted
<b>Deviation from Applicable Standard</b>		
As the customers' request, we adopt the above standards for testing.		

The above equipment was tested by Compliance Certification Services Inc. for compliance with the requirements set forth in the EMC Directive 89/336/EMC and the technical standards mentioned above. The results of testing in this report apply only to the product/system, which was tested. Other similar equipment will not necessarily produce the same results due to production tolerance and measurement uncertainties.

**Approved by:**

David Wang  
Manager of Hsintien Laboratory  
Compliance Certification Services Inc.

**Reviewed by:**

Vince Chiang  
Assistant Manager of Hsintien Laboratory  
Compliance Certification Services Inc.



## 2 EUT DESCRIPTION

<b>Product</b>	Analogue Output Control Card
<b>Trade Name</b>	ADVANTECH
<b>Model</b>	MIC-3723R
<b>Housing Type</b>	N/A
<b>EUT Power Rating</b>	$\pm 3\text{VDC}$ / $\pm 5\text{VDC}$ / $\pm 12\text{VDC}$ from Power Supply
<b>AC Power During Test</b>	230VAC, 50Hz
<b>Power Supply Manufacturer</b>	LEMACS (ZIPPY)
<b>Power Supply Model Number</b>	P1A-6250P
<b>AC Power Cord Type</b>	Unshielded, 1.8m (Detachable) to Power Supply
<b>OSC/Clock Frequencies</b>	N/A

### I/O PORT OF EUT

I/O PORT TYPE	Q' TY	TESTED WITH
1. SCSI Port	1	1

*Note: Client consigns only one model sample (Model Number is MIC-3723R) to test.*



### 3 TEST METHODOLOGY

#### 3.1 EUT SYSTEM OPERATION

1. Windows XP boots system.
2. Run "MIC-3680 Can\_Recv.exe" First windows choose 02: {CAN MIC-3680 I/O = ac00H Slot6 P1} choose "Select" button stand by.
3. Run "MIC-3680 Ca\_Send.exe" First windows choose 03: {CAN MIC-3680 I/O = b000H Slot6 P2} choose "Select" button, stand by choose "start" button choose "OK" button.
4. Run "MIC-3780\_Counter.exe" choose "start" button stand by.
5. Run "MIC-3753.exe".
6. Run "Advantech Device Manager" choose "004: <MIC-3780 BoardIO=0 I/O=a400H" choose second "test" button close "Advantech Device Manager".
7. Run "MIC-2723AO.exe" Observe "Advantech Device Test-MIC-3780" red and green lights glimmer in the window.

*Note: Test program is self-repeating throughout the test.*

#### 3.2 DECISION OF FINAL TEST MODE

1. The following test mode were scanned during the preliminary test:

**Mode:**

**1. Normal Mode**

2. After the preliminary scan, the following test mode was found to produce the highest emission level.

**Conduction:** Mode 1

**Radiation:** Mode 1

Then, the EUT configuration and cable configuration of the above highest emission mode was chosen for all final test items.



## 4 SETUP OF EQUIPMENT UNDER TEST

### Setup Diagram

See test photographs attached in Appendix I for the actual connections between EUT and support equipment.

### Support Equipment

#### Host PC Devices:

No	Equipment	Model #	Trade Name
1	HDD (20G)	MHT2020AT	FUJITSU
2	CPU (1.7GHz)	Pentium 4	Intel
3	RAM (512MB)	DDR266 SD	ELPIDA
4	Power Supply	P1A-6250P	LEMACE (ZIPPY)
5	Digital Input/Output Card	MIC-3753R	ADVANTECH
6	CAN Port Communication Card	MIC-3680R	ADVANTECH
7	Counter / Digital Inout Card	MIC-3780R	ADVANTECH
8	Motherboard	MIC-3318	ADVANTECH

#### Peripherals Devices:

No	Equipment	Model	Serial No.	FCC/ BSMI ID	Trade Name	Data Cable	Power Cord
1	USB 2.0 HDD	F12-U	N/A	BSMI ID: 4912A002	TeraSys	Shielded, 1.8m	N/A
2	USB 2.0 HDD	F12-U	N/A	BSMI ID: 4912A002	TeraSys	Shielded, 1.8m	N/A
3	PS/2 Mouse	M071KC	443029438	DOC BSMI: R41108	DELL	Shielded, 1.8m	N/A
4	PS/2 Keyboard	SK-8110	N/A	DOC BSMI: T3A002	DELL	Shielded, 1.8m	N/A
5	Modem	5JEG4033MK O	L0063CG2D007217	5RJTAI-35500-M5-E	TOP- SOLUTION	Shielded, 1.8m	Unshielded, 1.8m
6	Socket	N/A	N/A	N/A	N/A	N/A	N/A
7	Modem	5JEG4033MK O	L0063CG2D007217	5RJTAI-35500-M5-E	TOP- SOLUTION	Shielded, 1.8m	Unshielded, 1.8m
8	Server Notebook	PP05L	2464936188	DoC BSMI: R33002	DELL	Unshielded, 20m	Unshielded, 1.8m with a core
9	Server Notebook	M623	N/A	N/A	Fox	Unshielded, 20m	Unshielded, 1.8m

**Note:** All the above equipment/cables were placed in worse case positions to maximize emission signals during emission test.

**Grounding:** Grounding was in accordance with the manufacturer's requirements and conditions for the intended use.

## 5 FACILITIES AND ACCREDITATIONS

### 5.1 FACILITIES



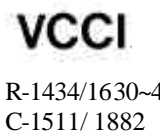




All measurement facilities used to collect the measurement data are located at CCS Taiwan Hsintien Lab at No. 163-1, Chunghsen Road, Hsintien City, Taipei Hsien, Taiwan.

The measurement facilities are constructed in conformance with the requirements of CISPR 16-1, ANSI C63.4 and other equivalent standards.

### 5.2 LABORATORY ACCREDITATIONS AND LISTINGS

The test facilities used to perform Electromagnetic compatibility tests are registered or accredited by the organizations listed in the following table which includes the recognized scope specifically.

This accredited organization maintains A2LA accreditation to ISO/IEC 17025 for the specific test listed in A2LA Certificate # 0824-01. The test results included in this report, however, are not covered by this accreditation.

Country	Agency	Scope of Accreditation	Logo
USA	A2LA	CFR 47, FCC Part 15/18; AS/NZS 3548; VCCI V3; CNS 13438; CNS 13439; CNS 13783; CNS 14115; CISPR 11/EN 55011; CISPR 14-1/EN 55014-1; CISPR 15/EN 55015; CISPR 22/EN 55022; EN 50081-1/EN 61000-6-3; EN 50082-1/EN 61000-6-4; IEC/EN 61000-4-2, IEC/EN 61000-4-3, IEC/EN 61000-4-4, IEC/EN 61000-4-5, IEC/EN 61000-4-6, IEC/EN 61000-4-8, IEC/EN 61000-4-11, IEC/EN 61000-3-2, IEC/EN 61000-3-3; CISPR 24/EN 55024; CISPR 14-2/EN 55014-2; EN 50081-2/EN 61000-6-1; EN 50082-2/EN 61000-6-2.	
USA	FCC	3/10 meter Open Area Test Sites to perform FCC Part 15/18 measurements	
Japan	VCCI	3/10 meter Open Area Test Sites and Line Conducted Test Room to perform conducted/radiated measurements	
Norway	NEMKO	EN 50081-1/2, EN 50082-1/2, IEC 61000-6-1/2/3/4, EN 50091-2, EN 50130-4, EN 55011, EN 55013, EN 55014-1/2, EN 55015, EN 55022, EN 55024, EN 61000-3-2/3, EN 61326-1, IEC 61000-4-2/3/4/5/6/8/11, Cisp16-1/2/3/4	
Taiwan	CNLA	47 CFR FCC Part 15 Subpart B, EN 61000-3-2, EN 61000-3-3, CNS 13439, CNS 13783-1, CNS 13438, AS/NZS 3548, VCCI, CNS 13022-1/2/3, EN 55022, EN 55013, EN 55014-1, EN 61000-4-2/3/4/5/6/8/11, ENV 50204, ENV 50141, ENV 50142	
Taiwan	BSMI	CNS 13438, CNS 13783-1, CNS 13439	
Canada	Industry Canada	RSS212, Issue 1	

**Note:** No part of this report may be used to claim or imply product endorsement by CNLA, A2LA or other government agency.





## 6 INSTRUMENT AND CALIBRATION

### 6.1 MEASURING INSTRUMENT CALIBRATION

The measuring equipment utilized to perform the tests documented in this report has been calibrated once a year or in accordance with the manufacturer's recommendations, and is traceable to recognized national standards.

### 6.2 TEST AND MEASUREMENT EQUIPMENT

The following list contains measurement equipment used for testing. The equipment conforms to the requirement of CISPR 16-1, ANSI C63.2 and other required standards.

Calibration of all test and measurement, including any accessories that may effect such calibration, is checked frequently to ensure the accuracy. Adjustments are made and correction factors are applied in accordance with the instructions contained in the respective manual.

#### Equipment Used for Emission Measurement

Open Area Test Site # I				
EQUIPMENT	MFR	MODEL	SERIAL NUMBER	CAL. DUE
SITE NSA	CCS	I Site	N/A	10/14/2006
MEASURE RECEIVER	SCHAFFNER	SCR3501	338	07/02/2007
SPECTRUM ANALYZER	ADVANTEST	R3132	120900008	No Calibration Required
ANTENNA	SCHAFFNER	CBL 6112B	2809	09/23/2006
AMPLIFIER	SCHAFFNER	CPA9231A	3626	10/08/2006
CABLE	BELDEN	9913	N-TYPE #12	02/17/2007
ATTENUATOR	MCL	UNAT-6	AT06-3	10/08/2006
THERMO-HYGRO METER	TFA	N/A	NO.2	11/02/2006
DECOUPLING NETWORK	FCC	F-201-DCN-5-6MM	22, 24	08/24/2006

*Note: The measurement uncertainty is less than +/- 3.36dB, which is evaluated as per the NAMAS NIS 81 and CISPR/A/291/CDV.*

Conducted Emission Test Site # B				
EQUIPMENT	MFR	MODEL	SERIAL NUMBER	CAL. DUE
TEST RECEIVER	R&S	ESHS10	843743/015	03/28/2007
LISN (EUT)	EMCO	3825/2	9106-1810	01/09/2007
LISN	EMCO	3825/2	1382	01/09/2007
BNC CABLE	MIYAZAKI	5D-FB	BNC B1	07/13/2007
Pulse Limiter	R&S	ESH3-Z2	100374	08/25/2006
THERMO-HYGRO METER	TOP	HA-202	9303-3	02/22/2007

*Note: The measurement uncertainty is less than +/- 2.83dB, which is evaluated as per the NAMAS NIS 81 and CISPR/A/291/CDV.*



Power Harmonic & Voltage Fluctuation/Flicker Test Site (EN 61000-3-2&-3-3)			
Manufacturer/Type	Model No.	Serial No.	Cal. Due
Schaffner / Signal Conditioning Unit	CCN 1000-1	72122	12/01/2006
Schaffner / 5KVA AC Power Source	NSG 1007	55131	No Calibration Required
Protronix / Digital Power Meter	1201	201091	08/29/2007

**Equipment Used for Immunity Measurement**

ESD Test Site (EN 61000-4-2)			
Manufacturer/Type	Model No.	Serial No.	Cal. Due
Schaffner / ESD Simulator	NSG 438	129	04/24/2007
Sato / Aneroid Barometer	7610-20	89090	08/29/2006
TOP / Thermo-Hygro meter	HA-202	9303-1	02/22/2007

Radiated Electromagnetic Field Immunity Test Site (EN 61000-4-3)			
Manufacturer/Type	Model No.	Serial No.	Cal. Due
Calibration of Field	Chamber#RS	200604H/V-2	04/11/2007
Agilent / Signal Generator	E4421B	MY43350597	05/17/2007
AR / Electric Field Probe	FP6001	305650	03/15/2007
Boonton / RF Voltmeter	9200B	328001AE	02/08/2007
BNC / Function Generator	625A	25451	02/08/2007
AR / Amplifier	100W1000M1	17564	No Calibration Required
AR / Direction Coupler	DC6180A	312189	No Calibration Required
AR / Broadband Antenna	AT1080	311819	No Calibration Required
TOP / Thermo-Hygro meter	HA-202	9303-2	02/22/2007

Fast Transients/Burst Test Site (EN 61000-4-4)			
Manufacturer/Type	Model No.	Serial No.	Cal. Due
Schaffner / EFT Generator	BEST EMC V2.3	200031A024SC	11/07/2006
Schaffner / Capacitive Clamp	N/A	N/A	No Calibration Required



Surge Immunity Test Site (EN 61000-4-5)			
Manufacturer/Type	Model No.	Serial No.	Cal. Due
Schaffner / Surger Generator	BEST EMC V2.3	200031A024SC	11/07/2006
Schaffner / Signal and Data Lines Coupling Network	CDN118	19328	No Calibration Required

CS test (EN 61000-4-6)			
Manufacturer/Type	Model No.	Serial No.	Cal. Due
Schaffner / RF Generator	NSG 2070-1	1061	08/01/2007
Schaffner / CDN	CDN M316	19600	08/01/2007
Schaffner / CDN	CDN M216	19294	08/01/2007
FCC / CDN	FCC-801-M3-16A	99122	08/01/2007
Schaffner / EM Clamp	KEMZ 801	19227	02/19/2007
Schaffner / CDN	CDN T002	15881	01/12/2007
FCC / CDN	FCC-801-T8-RJ45	04025	07/03/2007
Schaffner / Attenuator	INA2070-1	2061	No Calibration Required
FCC / CDN	FCC-801-T4-RJ45	04031	08/01/2007

Power Frequency Magnetic Field Immunity test (EN 61000-4-8)			
Manufacturer/Type	Model No.	Serial No.	Cal. Due
Schaffner / Induction Coil Interface	INA 21141	6009	No Calibration Required
Schaffner / 5KVA AC Power Source	NSG 1007	55131	No Calibration Required
CHY/ TRMS Clamp Meter	932C	2K0900285	10/16/2006
Sypris / Magnetic Field Meter	4080	0247	01/23/2007

Voltage Dips/Short Interruption and Voltage Variation Immunity test (EN 61000-4-11)			
Manufacturer/Type	Model No.	Serial No.	Cal. Due
Schaffner / Dips/Interruption/Variations Tester	BEST EMC V2.3	200031A024SC	11/07/2006

## 7 LINE CONDUCTED & RADIATED EMISSION TEST

### 7.1 LIMIT

#### 7.1.1 EN 55022

##### Maximum permissible level of Line Conducted Emission

FREQUENCY (MHz)	Class A (dBuV)		Class B (dBuV)	
	Quasi-peak	Average	Quasi-peak	Average
0.15 - 0.5	79	66	66 - 56	56 - 46
0.50 - 5.0	73	60	56	46
5.0 - 30.0	73	60	60	50

*Note: The lower limit shall apply at the transition frequency.*

##### Maximum permissible level of Common Mode Conducted Emission (Telecommunication Ports)

#### CLASS A

FREQUENCY (MHz)	Voltage Limit (dBuV)		Current Limit (dBuA)	
	Quasi-peak	Average	Quasi-peak	Average
0.15 - 0.5	97 - 87	84 - 74	53 - 43	40 - 30
0.5 - 30.0	87	74	43	30

#### CLASS B

FREQUENCY (MHz)	Voltage Limit (dBuV)		Current Limit (dBuA)	
	Quasi-peak	Average	Quasi-peak	Average
0.15 - 0.5	84 - 74	74 - 64	40 - 30	30 - 20
0.5 - 30.0	74	64	30	20

*Note: The lower limit shall apply at the transition frequency.*

##### Maximum permissible level of Radiated Emission measured at 10 meter

FREQUENCY (MHz)	Class A (dBuV/m)	Class B (dBuV/m)
	Quasi-peak	Quasi-peak
30 - 230	40	30
230 - 1000	47	37

*Note: The lower limit shall apply at the transition frequency.*

## 7.1.2 EN 55011

### Maximum permissible level of Mains terminal disturbance voltage (Conducted Emission)

#### CLASS A

FREQUENCY (MHz)	Group 1		Group 2		Group 2*	
	Quasi-peak (dBuV)	Average (dBuV)	Quasi-peak (dBuV)	Average (dBuV)	Quasi-peak (dBuV)	Average (dBuV)
0.15 - 0.5	79	66	100	90	130	120
0.50 - 5.0	73	60	86	76	125	115
5.0 - 30.0	73	60	90 Decreasing linearly with logarithm of frequency to 70	80 60	115	105

*Note: The lower limit shall apply at the transition frequency*

*Care should be taken to comply with leakage current requirements.*

#### CLASS B

FREQUENCY (MHz)	Group 1 & 2	
	Quasi-peak (dBuV)	Average (dBuV)
0.15 - 0.5	66 Decreasing linearly with logarithm of frequency to 56	56 Decreasing linearly with logarithm of frequency to 46
0.50 - 5.0	56	46
5.0 - 30.0	60	50

*Note: The lower limit shall apply at the transition frequency*

*Care should be taken to comply with leakage current requirements.*

### Maximum permissible level of Radiated Emission measured at 10 meter

FREQUENCY (MHz)	Measured on a test site		Measured in situation
	Group 1, class A	Group 1, class B	Group 1, class A Limits with measuring distance 30 m from exterior wall outside the building in which the equipment is situated
	Quasi-peak (dBuV/m)	Quasi-peak (dBuV/m)	Quasi-peak (dBuV/m)
0.15 - 30	Under consideration	Under consideration	Under consideration
30 - 230	40	30	30
230 - 1000	47	37	37

*Note: The lower limit shall apply at the transition frequency.*



## **7.2 TEST PROCEDURE OF LINE CONDUCTED EMISSION**

### **7.2.1 EN 55022**

#### **Procedure of Preliminary Test**

- The EUT was set up as per the test configuration to simulate typical usage per the user's manual. When the EUT is a tabletop system, a wooden table with a height of 0.8 meters is used and is placed on the ground plane as per EN 55022 (see Test Facility for the dimensions of the ground plane used). When the EUT is a floor-standing equipment, it is placed on the ground plane which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane.
- Support equipment, if needed, was placed as per EN 55022.
- All I/O cables were positioned to simulate typical actual usage as per EN 55022.
- The test system with EUT received AC power, 230V/50Hz, through a Line Impedance Stabilization Network (LISN), which supplied power source and was grounded to the ground plane.
- All support equipment received power from a second LISN.
- The EUT test program was started. Emissions were measured on each current carrying line of the EUT using an EMI Test Receiver connected to the LISN powering the EUT.
- The Receiver scanned from 150kHz to 30MHz for emissions in each of the test modes.
- During the above scans, the emissions were maximized by cable manipulation.
- The test mode(s) described in Item 3.2 were scanned during the preliminary test.
- After the preliminary scan, we found the test mode described in Item 3.2 producing the highest emission level.
- The EUT configuration and cable configuration of the above highest emission level were recorded for reference of the final test.

#### **Procedure of Final Test**

- EUT and support equipment were set up on the test bench as per the configuration with highest emission level in the preliminary test.
- A scan was taken on both power lines, Line 1 and Line 2, recording at least the six highest emissions. Emission frequency and amplitude were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit. If EUT emission level was less -2dB to the Average limit in Q.P. mode, then the emission signal was re-checked using an Average detector.
- The test data of the worst-case condition(s) was recorded.

**Data Sample:**

Freq. MHz	Read Level dBuV	Factor dB	Level dBuV	Limit dBuV	Over Limit dB	Reading Type (P/Q/A)	Line (L1/L2)
x.xx	42.95	0.55	43.50	73	-29.50	Q	L1

Freq. = Emission frequency in MHz  
Read Level = Uncorrected Analyzer/Receiver reading  
Factor = Insertion loss of LISN + Cable Loss  
Level = Read Level + Factor  
Limit = Limit stated in standard  
Over Limit = Reading in reference to limit  
P = Peak Reading  
Q = Quasi-peak Reading  
A = Average Reading  
L1 = Hot side  
L2 = Neutral side

**Calculation Formula**

Over Limit (dB) = Level (dBuV) – Limit (dBuV)

**7.2.2 EN 55011****Procedure of Preliminary Test**

- The EUT was set up as per the test configuration to simulate typical usage per the user's manual. When the EUT is a tabletop system, a wooden table with a height of 0.8 meters is used and is placed on the ground plane as per EN 55011 (see Test Facility for the dimensions of the ground plane used). When the EUT is a floor-standing equipment, it is placed on the ground plane which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane.
- Support equipment, if needed, was placed as per EN 55011.
- All I/O cables were positioned to simulate typical actual usage as per EN 55011.
- The test equipment EUT installed received AC power, 230V/50Hz, through a Line Impedance Stabilization Network (LISN), which supplied power source and was grounded to the ground plane.
- All support equipment received power from a second LISN.
- The EUT test program was started. Emissions were measured on each current carrying line of the EUT using an EMI Test Receiver connected to the LISN powering the EUT.
- The Receiver scanned from 150kHz to 30MHz for emissions in each of the test modes.
- During the above scans, the emissions were maximized by cable manipulation.
- The test mode(s) described in Item 3.2 were scanned during the preliminary test.



- After the preliminary scan, we found the test mode described in Item 3.2 producing the highest emission level.
- The EUT configuration and cable configuration of the above highest emission level were recorded for reference of the final test.

### **Procedure of Final Test**

- EUT and support equipment were set up on the test bench as per the configuration with highest emission level in the preliminary test.
- A scan was taken on both power lines, Line 1 and Line 2, recording at least the six highest emissions. Emission frequency and amplitude were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit. If EUT emission level was less –2dB to the Average limit in Q.P. mode, then the emission signal was re-checked using an Average detector.
- The test data of the worst-case condition(s) was recorded.

### **Data Sample:**

Freq. MHz	Read Level dBuV	Factor dB	Level dBuV	Limit dBuV	Over Limit dB	Reading Type (P/Q/A)	Line (L1/L2)
x.xx	42.95	0.55	43.50	73	-29.50	Q	L1

Freq. = Emission frequency in MHz  
Read Level = Uncorrected Analyzer/Receiver reading  
Factor = Insertion loss of LISN + Cable Loss  
Level = Read Level + Factor  
Limit = Limit stated in standard  
Over Limit = Reading in reference to limit  
P = Peak Reading  
Q = Quasi-peak Reading  
A = Average Reading  
L1 = Hot side  
L2 = Neutral side

### **Calculation Formula**

Over Limit (dB) = Level (dBuV) – Limit (dBuV)





## 7.3 TEST PROCEDURE OF COMMON MODE CONDUCTED EMISSION FOR TELECOMMUNICATION PORT

### 7.3.1 EN55022

- Selecting ISN for unscreened cable or a current probe for screened cable to take measurement.
- The port of the EUT was connected to the remote side support equipment through the ISN/Current Probe and communication in normal condition.
- Making a overall range scan by using the test receiver controlled by controller and record at least six highest emissions for showing in the test report.
- Emission frequency and amplitude were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit.
- In case of measuring on the screened cable, the current limit shall be applied, otherwise the voltage limit should be applied.
- The following test mode(s) were scanned during the preliminary test:

N/A

- After the preliminary scan, we found the following test mode(s) producing the highest emission level and test data of the worst case was recorded.

N/A

#### Data Sample:

Freq. MHz	Read Level dBuV	Factor dB	Level dBuV	Limit dBuV	Over Limit dB	Reading Type (P/Q/A)
x.xx	62.95	0.55	63.50	87	-23.50	Q

Freq. = Emission frequency in MHz  
Read Level = Uncorrected Analyzer/Receiver reading  
Factor = Insertion loss of ISN + Cable Loss  
Level = Read Level + Factor  
Limit = Limit stated in standard  
Over Limit = Reading in reference to limit  
P = Peak Reading  
Q = Quasi-peak Reading  
A = Average Reading

#### Calculation Formula

Over Limit (dB) = Level (dBuV) – Limit (dBuV)



## **7.4 TEST PROCEDURE OF RADIATED EMISSION**

### **7.4.1 EN 55022**

#### **Procedure of Preliminary Test**

- The equipment was set up as per the test configuration to simulate typical usage per the user's manual. When the EUT is a tabletop system, a wooden turntable with a height of 0.8 meters is used which is placed on the ground plane. When the EUT is a floor-standing equipment, it is placed on the ground plane which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane.
- Support equipment, if needed, was placed as per EN 55022.
- All I/O cables were positioned to simulate typical usage as per EN 55022.
- The EUT received AC power source, 230V/50Hz, from the outlet socket under the turntable. All support equipment received power from another socket under the turntable.
- Mains cables, telephone lines or other connections to auxiliary equipment located outside the test are shall drape to the floor, be fitted with ferrite clamps or ferrite tubes placed on the floor at the point where the cable reaches the floor and then routed to the place where they leave the turntable. No. extension cords shall be used to mains receptacle.
- The antenna was placed at 10 meter away from the EUT as stated in EN 55022. The antenna connected to the Spectrum Analyzer via a cable and at times a pre-amplifier would be used.
- The Analyzer / Receiver quickly scanned from 30MHz to 1000MHz. The EUT test program was started. Emissions were scanned and measured rotating the EUT to 360 degrees and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.
- The test mode(s) described in Item 3.2 were scanned during the preliminary test:
- After the preliminary scan, we found the test mode described in Item 3.2 producing the highest emission level.
- The EUT and cable configuration, antenna position, polarization and turntable position of the above highest emission level were recorded for the final test.

#### **Procedure of Final Test**

- EUT and support equipment were set up on the turntable as per the configuration with highest emission level in the preliminary test.
- The Analyzer / Receiver scanned from 30MHz to 1000MHz. Emissions were scanned and measured rotating the EUT to 360 degrees, varying cable placement and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.



- Recorded at least the six highest emissions. Emission frequency, amplitude, antenna position, polarization and turntable position were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit and only Q.P. reading is presented.

**Data Sample:**

Freq. MHz	Read Level dBuV	Factor dB/m	Level dBuV/m	Limit dBuV/m	Over Limit dB	Reading Type (P/Q/A)	Pol. (H/V)
x.xx	14.0	12.2	26.2	40	-13.8	Q	H

Freq. = Emission frequency in MHz  
Reading = Uncorrected Analyzer/Receiver reading  
Factor = Antenna Factor + Cable Loss + Attenuator (3/6/10dB) – Amplifier Gain  
Amptd = Uncorrected Analyzer/Receiver reading + Factor  
Limit = Limit stated in standard  
Margin = Reading in reference to limit  
P = Peak Reading  
Q = Quasi-peak Reading  
A = Average Reading  
H = Antenna Polarization: Horizontal  
V = Antenna Polarization: Vertical

**Calculation Formula**

Margin (dB) = Amptd (dBuV/m) – Limit (dBuV/m)



## **7.4.2 EN 55011**

### **Procedure of Preliminary Test**

- The equipment was set up as per the test configuration to simulate typical usage per the user's manual. When the EUT is a tabletop system, a wooden turntable with a height of 0.8 meters is used which is placed on the ground plane. When the EUT is a floor-standing equipment, it is placed on the ground plane which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane.
- Support equipment, if needed, was placed as per EN 55011.
- All I/O cables were positioned to simulate typical usage as per EN 55011.
- The EUT received AC power source, 230V/50Hz, from the outlet socket under the turntable. All support equipment received power from another socket under the turntable.
- The antenna was placed at 10 meter away from the EUT as stated in EN 55011. The antenna connected to the Spectrum Analyzer via a cable and at times a pre-amplifier would be used.
- The Analyzer / Receiver quickly scanned from 30MHz to 1000MHz. The EUT test program was started. Emissions were scanned and measured rotating the EUT to 360 degrees and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.
- The test mode(s) described in Item 3.2 were scanned during the preliminary test:
- After the preliminary scan, we found the test mode described in Item 3.2 producing the highest emission level.
- The EUT and cable configuration, antenna position, polarization and turntable position of the above highest emission level were recorded for the final test.

### **Procedure of Final Test**

- EUT and support equipment were set up on the turntable as per the configuration with highest emission level in the preliminary test.
- The Analyzer / Receiver scanned from 30MHz to 1000MHz. Emissions were scanned and measured rotating the EUT to 360 degrees, varying cable placement and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.
- Recorded at least the six highest emissions. Emission frequency, amplitude, antenna position, polarization and turntable position were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit and only Q.P. reading is presented.
- The test data of the worst-case condition(s) was recorded.

**Data Sample:**

Freq. MHz	Read Level dBuV	Factor dB/m	Level dBuV/m	Limit dBuV/m	Over Limit dB	Reading Type (P/Q/A)	Pol. (H/V)
x.xx	14.0	12.2	26.2	40	-13.8	Q	H

Freq. = Emission frequency in MHz  
Reading = Uncorrected Analyzer/Receiver reading  
Factor = Antenna Factor + Cable Loss + Attenuator (3/6/10dB) – Amplifier Gain  
Amptd = Uncorrected Analyzer/Receiver reading + Factor  
Limit = Limit stated in standard  
Margin = Reading in reference to limit  
P = Peak Reading  
Q = Quasi-peak Reading  
A = Average Reading  
H = Antenna Polarization: Horizontal  
V = Antenna Polarization: Vertical

**Calculation Formula**

Margin (dB) = Amptd (dBuV/m) – Limit (dBuV/m)



## 7.5 TEST RESULTS

### Line Conducted Emission

**Model:** MIC-3723R**Test Mode:** Mode 1**Temperature:** 23°C**Humidity:** 65% RH**Test Results:** Passed**Tested by:** John Yen

(The chart below shows the highest readings taken from the final data.)

Six Highest Conducted Emission Readings							
Frequency Range Investigated				150 kHz to 30 MHz			
Freq (MHz)	Read Level (dBuV)	Factor (dB)	Level (dBuV)	Limit Line (dBuV)	Over Limit (dB)	Reading Type (P/Q/A)	Line (L1/L2)
0.168	44.92	9.94	54.86	79.00	-24.14	P	L1
0.203	43.77	9.93	53.70	79.00	-25.30	P	L1
0.263	40.08	9.88	49.96	79.00	-29.04	P	L1
0.150	42.06	9.99	52.05	79.00	-26.95	P	L2
0.164	40.32	9.97	50.29	79.00	-28.71	P	L2
0.243	34.41	9.89	44.30	79.00	-34.70	P	L2

*NOTE: The emission level was or more than 2dB below the Average limit, so no re-check anymore.*

### Common Mode Conducted Emission

*Not applicable.*

**Radiated Emission****Model:** MIC-3723R**Test Mode:** Mode 1**Temperature:** 24°C**Humidity:** 55% RH**Test Results:** Passed**Tested by:** Mark Hsu

(The chart below shows the highest readings taken from the final data.)

Six Highest Radiated Emission Readings							
Frequency Range Investigated				30 MHz to 1000 MHz at 10m			
Freq (MHz)	Amptd (dBuV/m)	Margin (dB)	Limit (dBuV/m)	Reading (dBuV)	Factor (dB/m)	Reading Type (P/Q/A)	Pol. (H/V)
125.006	36.30	-9.05	27.25	40.00	-12.75	Q	V
133.315	35.60	-9.33	26.27	40.00	-13.73	Q	V
147.170	36.70	-9.97	26.73	40.00	-13.27	Q	V
125.016	35.10	-9.05	26.05	40.00	-13.95	Q	H
133.293	34.70	-9.33	25.37	40.00	-14.63	Q	H
147.165	35.20	-9.96	25.24	40.00	-14.76	Q	H

*NOTE: None.*



## 8 POWER HARMONICS TEST

**Port** : AC Power Port  
**Basic Standard** : EN 61000-3-2 (2000)  
**Limits** : ☐ CLASS A ; ☒ CLASS D  
**Tested by** : Mark Hsu  
**Temperature** : 19°C  
**Humidity** : 50%

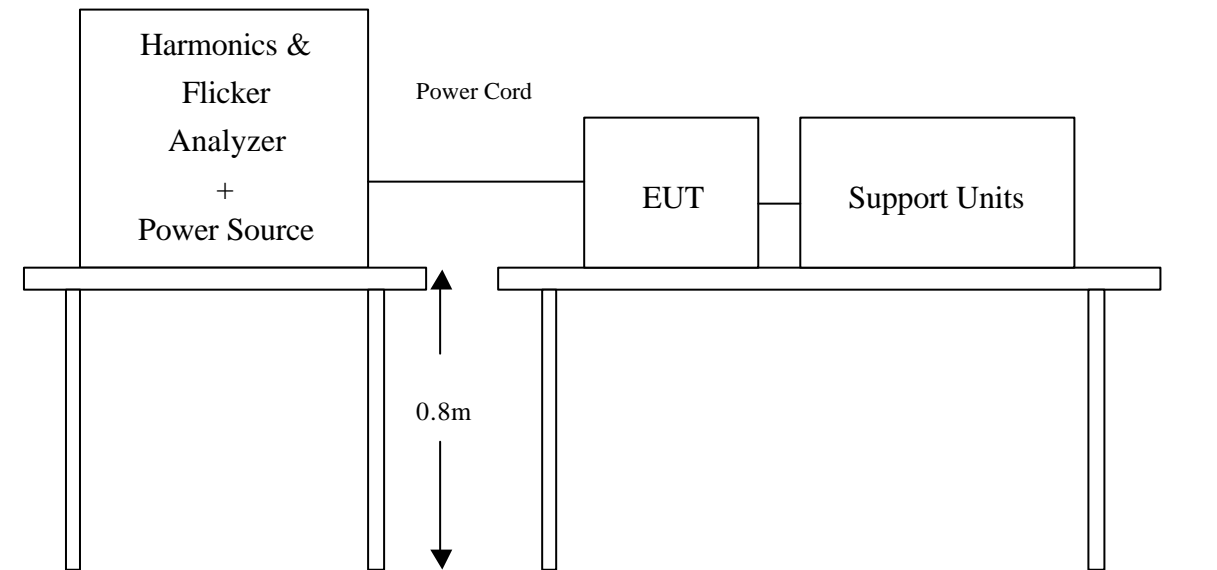
### Limit:

Limits for Class A equipment	
Harmonics Order n	Max. permissible harmonics current A
Odd harmonics	
3	2.30
5	1.14
7	0.77
9	0.40
11	0.33
13	0.21
15≤n≤39	0.15x15/n
Even harmonics	
2	1.08
4	0.43
6	0.30
8≤n≤40	0.23x8/n

Limits for Class D equipment		
Harmonics Order n	Max. permissible harmonics current per watt mA/W	Max. permissible harmonics current A
Odd Harmonics only		
3	3.4	2.30
5	1.9	1.14
7	1.0	0.77
9	0.5	0.40
11	0.35	0.33
13	0.30	0.21
15≤n≤39	3.85/n	0.15x15/n



### **Block Diagram of Test Setup:**



### **Test Procedure:**

- The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic components under normal operating conditions for each successive harmonic component in turn.
- The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the time necessary for the EUT to be exercised.

### **Test Result :** (See Appendix II for details)

<input checked="checked" type="checkbox"/> <b>PASS</b> <input type="checkbox"/> <b>FAIL</b>
<b>Note:</b> None.

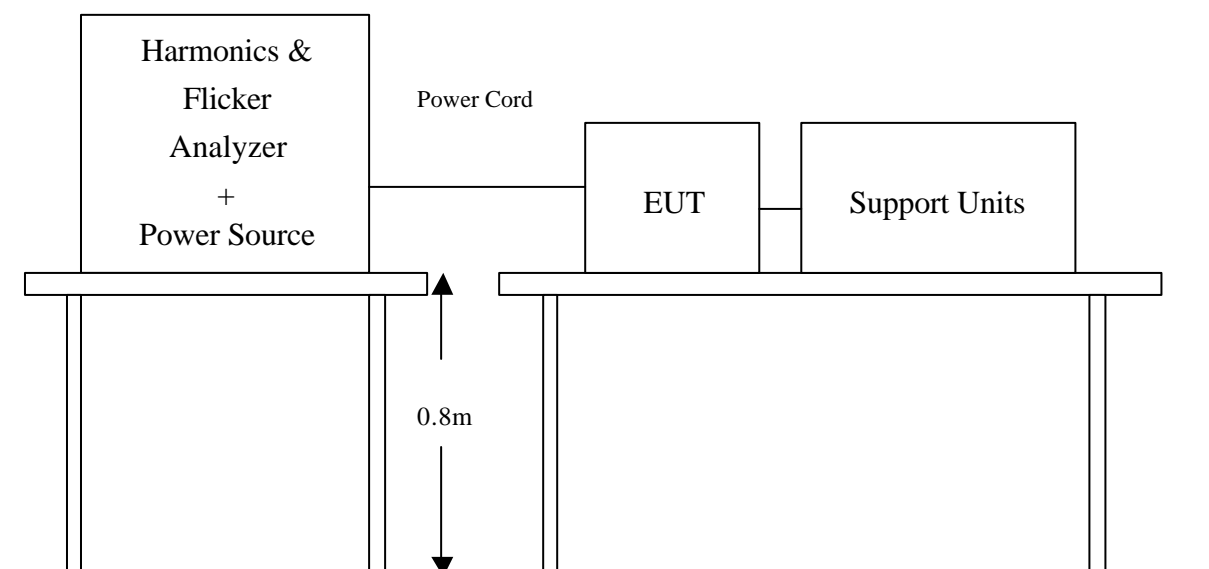
## 9 POWER VOLTAGE FLUCTUATION / FLICKER TEST

**Port** : AC Power Port  
**Basic Standard** : EN 61000-3-3 (1995 + A1: 2001)  
**Limits** : § of EN 61000-3-3  
**Tested by** : Mark Hsu  
**Temperature** : 19°C  
**Humidity** : 50%

### Limit:

TEST ITEM	LIMIT	REMARK
$P_{st}$	1.0	$P_{st}$ means short-term flicker indicator.
$P_{lt}$	0.65	$P_{lt}$ means long-term flicker indicator.
$T_{dt}$ (ms)	500	$T_{dt}$ means maximum time that dt exceeds 3.3 %.
$d_{max}$ (%)	4%	$d_{max}$ means maximum relative voltage change.
dc (%)	3.3%	dc means relative steady-state voltage change

### Block Diagram of Test Setup:



**Test Procedure:**

- a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under normal operating conditions.
- b. During the flick measurement, the measure time shall include that part of whole operation cycle in which the EUT produce the most unfavorable sequence of voltage changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.

**Test Result:** (See Appendix II for details)

TEST PARAMETER	MEASUREMENT VALUE	LIMIT	RESULT
$P_{st}$	0.001	1.0	Pass
$P_{lt}$	0.001	0.65	Pass
$T_{dt}$ (ms)	0	500	Pass
$d_{max}$ (%)	0	4%	Pass
dc (%)	0	3.3%	Pass

**Note:** None.

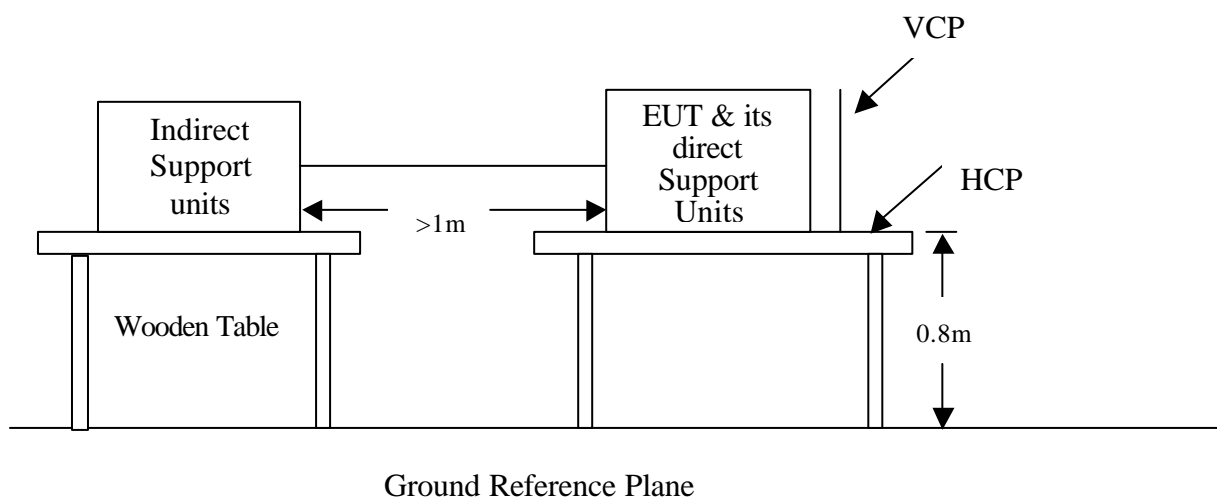
## 10 ELECTROSTATIC DISCHARGE (ESD) IMMUNITY TEST

### 10.1 EN 55024

<b>Port</b>	: Enclosure
<b>Basic Standard</b>	: IEC/EN 61000-4-2
<b>Test Level</b>	: $\pm 8$ kV (Air Discharge) $\pm 4$ kV (Contact Discharge) $\pm 4$ kV (Indirect Discharge)
<b>Performance Criterion</b>	: B (Standard Required)
<b>Tested by</b>	: Mark Hsu
<b>Temperature</b>	: 19°C
<b>Humidity</b>	: 50%
<b>Pressure</b>	: 1010mbar

#### **Block Diagram of Test Setup:**

(The 470 k ohm resistors are installed per standard requirement.)



**Test Procedure:**

1. The EUT was located 0.1 m minimum from all sides of the HCP.
2. The indirect support units were located 1 m minimum away from the EUT, but direct support unit was/were located at same location as EUT on the HCP and keep at a distance of 10 cm with EUT.
3. As per the requirement of EN 55024; applying direct contact discharge at the sides other than front of EUT at minimum 50 discharges (25 positive and 25 negative) if applicable, can't be applied direct contact discharge side of EUT then the indirect discharge shall be applied. One of the test points shall be subjected to at least 50 indirect discharge (contact) to the front edge of horizontal coupling plane.
4. Other parts of EUT where it is not possible to perform contact discharge then selecting appropriate points of EUT for air discharge, a minimum of 10 single air discharges shall be applied.
5. The application of ESD to the contact of open connectors is not required.
6. The EUT direct connection units also need to be applied ESD at the port of EUT cable connected.
7. Putting a mark on EUT to show tested points. The following test condition was followed during the tests.

*Note: As per IEC/EN 61000-4-2, two 470k bleed resistors cable is connected between the EUT and HCP during the test applicable for power ungrounded or battery operating unit only.*

The electrostatic discharges were applied as follows:

Amount of discharge	Voltage	Coupling	Result (Pass/Fail)
Min. 10 /Point	$\pm 8$ kV	Air Discharge	No Discharge Point
Min. 25 /Point	$\pm 4$ kV	Contact Discharge	No Discharge Point
Min. 25 /Point	$\pm 4$ kV	Indirect Discharge HCP (Front)	Pass
Min. 25 /Point	$\pm 4$ kV	Indirect Discharge VCP (Right)	Pass
Min. 25 /Point	$\pm 4$ kV	Indirect Discharge VCP (Left)	Pass
Min. 25 /Point	$\pm 4$ kV	Indirect Discharge VCP (Back)	Pass



### **Performance & Result:**

- ☒ **Criterion A:** The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
- ☐ **Criterion B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- ☐ **Criterion C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

☒ **PASS**      ☐ **FAIL**

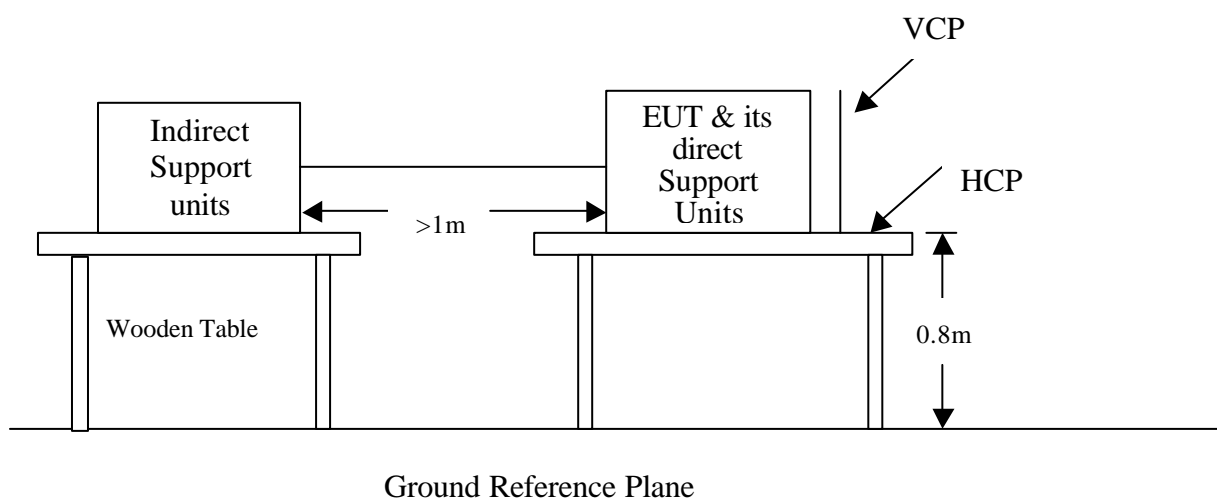
**Observation:** No function degraded during the tests.

**10.2 EN 61000-6-2**

<b>Port</b>	: Enclosure
<b>Basic Standard</b>	: IEC/EN 61000-4-2
<b>Test Level</b>	: $\pm 8$ kV (Air Discharge) $\pm 4$ kV (Contact Discharge) $\pm 4$ kV (Indirect Discharge)
<b>Performance Criterion</b>	: B (Standard Required)
<b>Tested by</b>	: Mark Hsu
<b>Temperature</b>	: 19°C
<b>Humidity</b>	: 50%
<b>Pressure</b>	: 1010mbar

**Block Diagram of Test Setup:**

(The 470 k ohm resistors are installed per standard requirement.)



**Test Procedure:**

1. The EUT was located 0.1 m minimum from all sides of the HCP.
2. The indirect support units were located 1 m minimum away from the EUT, but direct support unit was/were located at same location as EUT on the HCP and keep at a distance of 10 cm with EUT.
3. A scroll 'H' test program was loaded and executed in Windows XP mode.
4. The EUT sent above message to LCD Panel of Notebook PC at remote side and related peripherals through the test.
5. Active the communication function if the EUT with such port(s).
6. As per the requirement of IEC 61000-4-2; applying direct contact discharge each point at minimum 20 discharges (10 positive and 10 negative) if applicable, for the points can't be applied direct contact discharge then the indirect discharge shall be applied. One of the test points shall be subjected to at least 20 indirect discharge (contact) to the front edge of horizontal coupling plane and each side of EUT via vertical coupling plane .
7. Other parts of EUT where it is not possible to perform contact discharge then selecting appropriate points of EUT for air discharge, a minimum of 20 single air discharges shall be applied.
8. The application of ESD to the contact of open connectors is not required.
9. The EUT direct connection units also need to be applied ESD at the port of EUT cable connected.
10. Putting a mark on EUT to show tested points. The following test condition was followed during the tests.

**Note:** As per EN 61000-4-2, two 470k bleed resistors cable is connected between the EUT and HCP during the test applicable for power ungrounded or battery operating unit only.

The electrostatic discharges were applied as follows:

Amount of discharge	Voltage	Coupling	Result (Pass/Fail)
Min. 10 /Point	± 8 kV	Air Discharge	No Discharge Point
Min. 10 /Point	± 4 kV	Contact Discharge	No Discharge Point
Min. 10 /Point	± 4 kV	Indirect Discharge HCP (Front)	Pass
Min. 10 /Point	± 4 kV	Indirect Discharge VCP (Right)	Pass
Min. 10 /Point	± 4 kV	Indirect Discharge VCP (Left)	Pass
Min. 10 /Point	± 4 kV	Indirect Discharge VCP (Back)	Pass





## **Performance & Result:**

- ☒ **Criterion A:** The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
- ☐ **Criterion B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- ☐ **Criterion C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

☒ **PASS**      ☐ **FAIL**

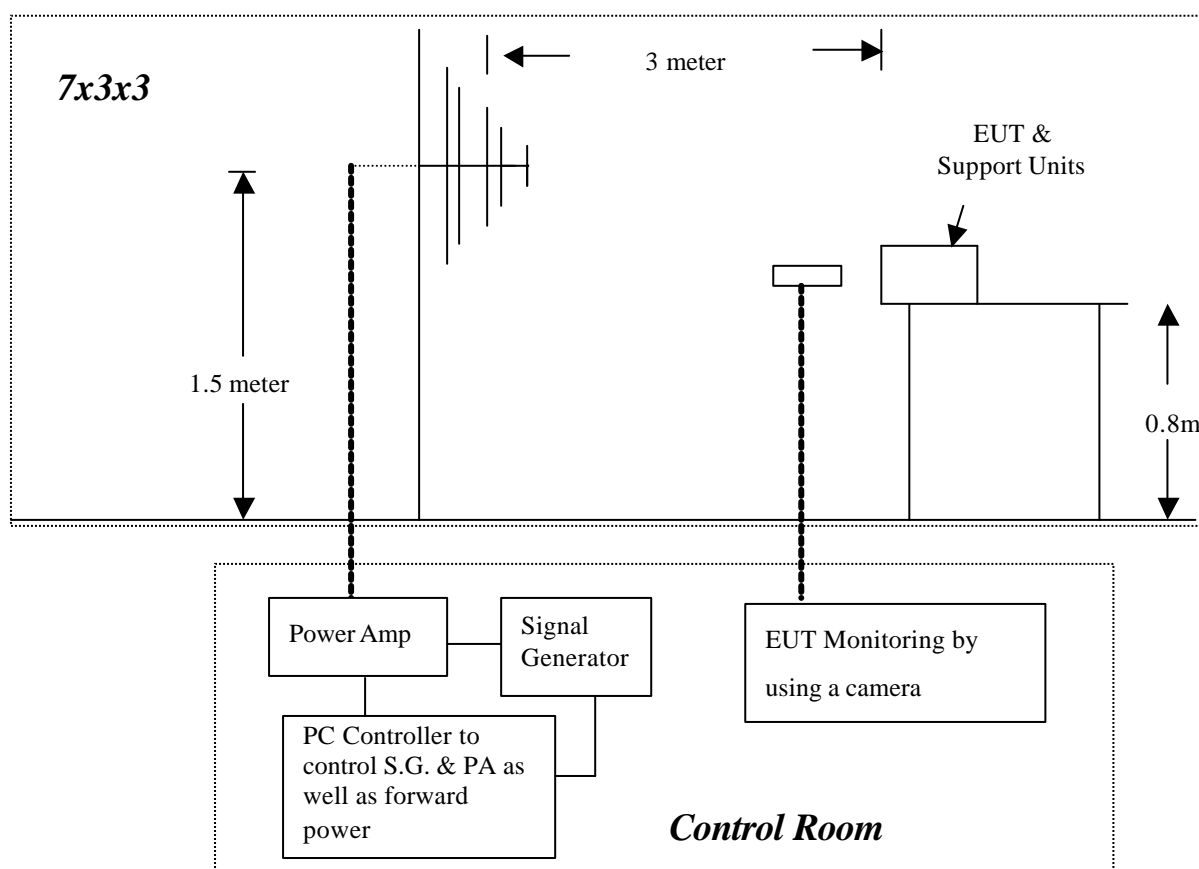
**Observation:** No function degraded during the tests.

# 11 RADIATED ELECTROMAGNETIC FIELD IMMUNITY TEST

## 11.1 EN 55024

Port	: Enclosure
Basic Standard	: IEC/EN 61000-4-3
Requirements	: 3 V/m / with 80% AM. 1kHz Modulation.
Performance Criterion:	A (Standard Required)
Tested by	: Mark Hsu
Temperature	: 21°C
Humidity	: 50%
Pressure	: 1010mbar

### Block Diagram of Test Setup:



**Test Procedure:**

1. The EUT and support units were located at the edge of supporting table keep 3 meter away from transmitting antenna, it just the calibrated square area of field uniformity.
2. Adjusting the cables to be exposed to the electromagnetic field as possible.
3. Performing a Radiated Emission Scan in range of 80 to 1000 MHz prior to do RS test and records the more higher emission frequencies for the reference of RS test, due to antenna effectiveness.
4. Adjusting the monitoring camera to monitor the “H” message as clear as possible.
5. Setting the testing parameters of RS test software per IEC 61000-4-3.
6. Referring to the tested data of step 3 to performing the RS test from 80 to 1000 MHz.
7. Recording the test result in following table.
8. Changing the EUT to the other side and repeat step 3 to 6, until 4 sides of EUT were verified.

**IEC 61000-4-3 Final test conditions:**

Test level : 3V/m

Steps : 1 % of fundamental

Dwell Time : 3 sec

Range (MHz)	Field	Modulation	Polarity	Position (°)	Result (Pass/Fail)
80-1000	3V/m	Yes	H	Front	Pass
80-1000	3V/m	Yes	V	Front	Pass
80-1000	3V/m	Yes	H	Right	Pass
80-1000	3V/m	Yes	V	Right	Pass
80-1000	3V/m	Yes	H	Back	Pass
80-1000	3V/m	Yes	V	Back	Pass
80-1000	3V/m	Yes	H	Left	Pass
80-1000	3V/m	Yes	V	Left	Pass



### **Performance & Result:**

- ☒ **Criterion A:** The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
- ☐ **Criterion B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- ☐ **Criterion C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

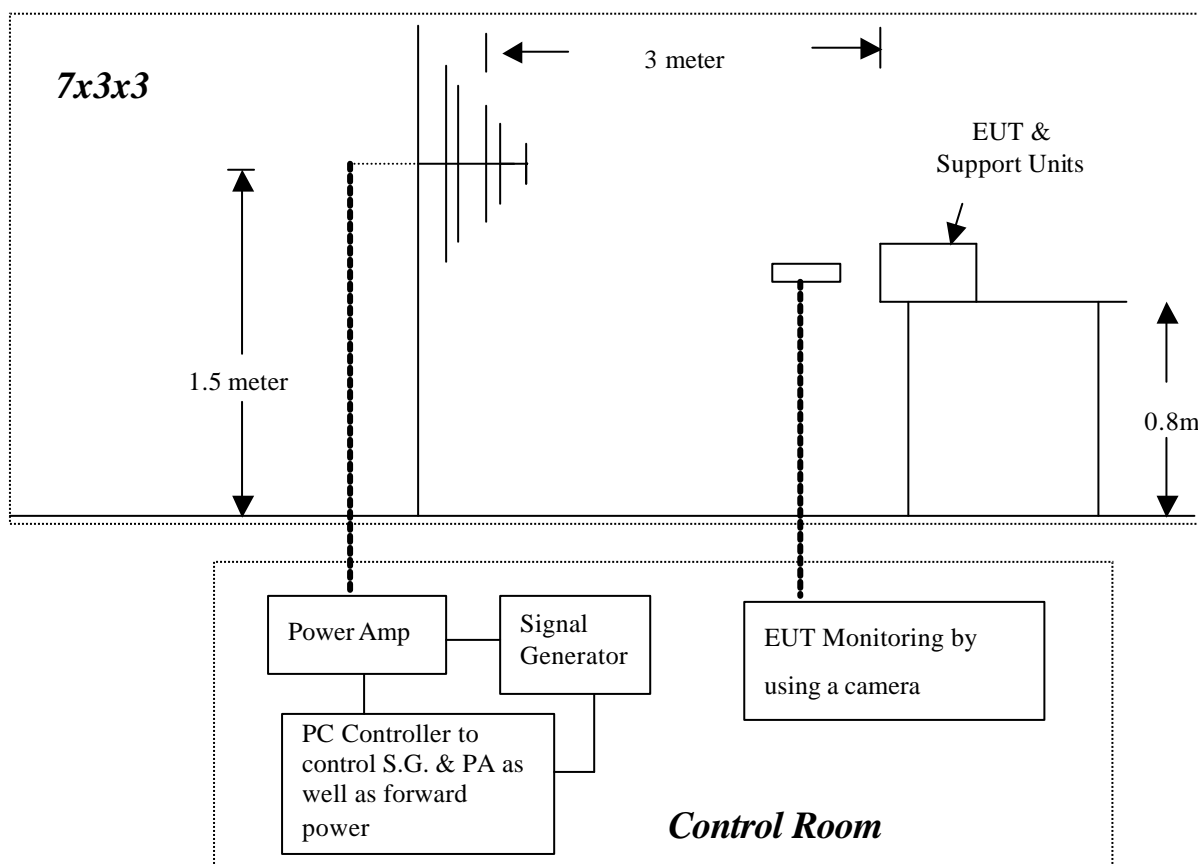
☒ **PASS**      ☐ **FAIL**

**Observation:** No function degraded during the tests.

## 11.2 EN 61000-6-2

<b>Port</b>	: Enclosure
<b>Basic Standard</b>	: IEC/EN 61000-4-3
<b>Requirements</b>	: 10 V/m / with 80% AM. 1kHz Modulation.
<b>Performance Criterion:</b>	A (Standard Required)
<b>Tested by</b>	: Mark Hsu
<b>Temperature</b>	: 21°C
<b>Humidity</b>	: 50%
<b>Pressure</b>	: 1010mbar

### Block Diagram of Test Setup:



**Test Procedure:**

9. The EUT was located at the edge of supporting table keep 3 meter away from transmitting antenna, it just the calibrated square area of field uniformity. The support units were located outside of the uniformity area, but the cable(s) connected with EUT were exposed to the calibrated field as per IEC/EN 61000-4-3.
10. Set the testing parameters of RS test software per IEC/EN 61000-4-3.
11. From the result of pre-test in step 3, choice the worst side of EUT for final test from 80 MHz to 1000 MHz at 1% steps.
12. Recorded the test result in following table.

**Final test conditions:**

Test level : 10V/m  
Steps : 1 % of fundamental  
Dwell Time : 3 sec

Range (MHz)	Field	Modulation	Polarity	Position	Result (Pass/Fail)
80-1000	10V/m	Yes	H	Front	Pass
80-1000	10V/m	Yes	V	Front	Pass
80-1000	10V/m	Yes	H	Right	Pass
80-1000	10V/m	Yes	V	Right	Pass
80-1000	10V/m	Yes	H	Back	Pass
80-1000	10V/m	Yes	V	Back	Pass
80-1000	10V/m	Yes	H	Left	Pass
80-1000	10V/m	Yes	V	Left	Pass

**Performance & Result:**

- ☒ **Criterion A:** The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
- ☐ **Criterion B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- ☐ **Criterion C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

☒ **PASS**      ☐ **FAIL**

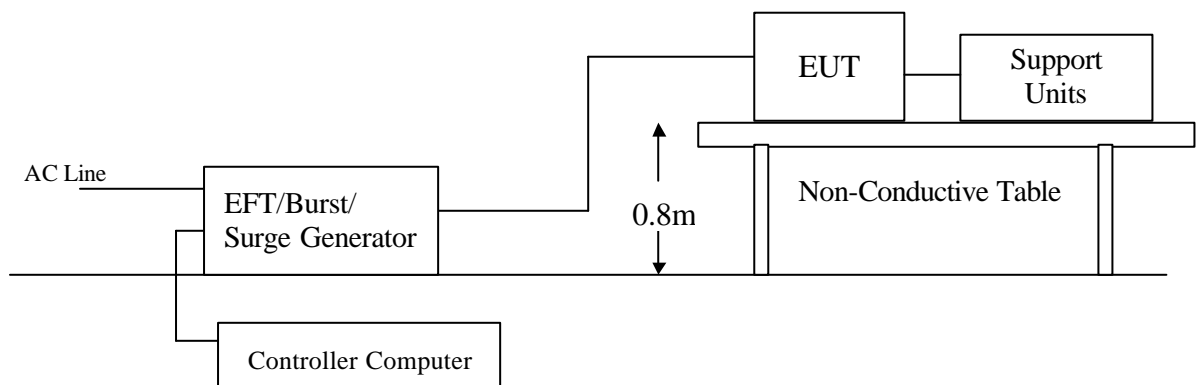
**Observation:** No function degraded during the tests.

## 12 FAST TRANSIENTS/BURST IMMUNITY TEST

### 12.1 EN 55024

Port	: AC Power Port
Basic Standard	: IEC/EN 61000-4-4
Requirements	: $\pm 1$ kV for AC Power Port
Performance Criteria	: B (Standard Required)
Tested by	: Mark Hsu
Temperature	: 19°C
Humidity	: 50%
Pressure	: 1010mbar

#### Block Diagram of Test Setup:



#### Test Procedure:

1. The EUT and support units were located on a wooden table 0.8 m away from ground reference plane.
2. A 1.0 meter long power cord was attached to EUT during the test.
3. The length of communication cable between communication port and clamp was keeping within 1 meter.
4. Injected test voltage to the EUT ports from minimum to standard request or client request.
5. Recorded the test result as shown in following table.



**Test conditions:**

Impulse Frequency : 5kHz

Tr/Th : 5/50ns

Burst Duration : 15ms

Burst Period : 300ms

Inject Line	Voltage kV	Inject Method	Result (Pass/Fail)
L	$\pm 1$	Direct	Pass
N	$\pm 1$	Direct	Pass
PE	$\pm 1$	Direct	Pass
L + N	$\pm 1$	Direct	Pass
L + PE	$\pm 1$	Direct	Pass
N + PE	$\pm 1$	Direct	Pass
L + N + PE	$\pm 1$	Direct	Pass

**Performance & Result:**

**Criterion A:** The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.



**Criterion B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.



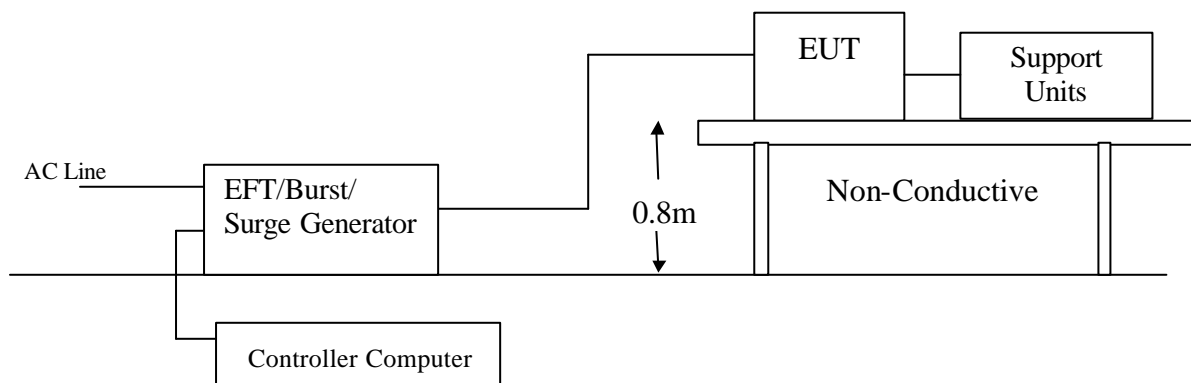
**Criterion C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

**PASS****FAIL**

**Observation:** No function degraded during the tests.

**12.2 EN 61000-6-2**

<b>Port</b>	: AC Power Port
<b>Basic Standard</b>	: IEC/EN 61000-4-4
<b>Requirements</b>	: $\pm 2$ kV for AC Power Port
<b>Performance Criteria</b>	: B (Standard Required)
<b>Tested by</b>	: Mark Hsu
<b>Temperature</b>	: 19°C
<b>Humidity</b>	: 50%
<b>Pressure</b>	: 1010mbar

**Block Diagram of Test Setup:****Test Procedure:**

1. The EUT and support units were located on a wooden table 0.8 m away from ground reference plane.
2. A 1.0 meter long power cord was attached to EUT during the test.
3. The length of communication cable between communication port and clamp was keeping within 1 meter.
4. Injected test voltage to the EUT ports from minimum to standard request or client request.
5. Recorded the test result as shown in following table.

**Test conditions:**

Impulse Frequency : 5kHz

Tr/Th : 5/50ns

Burst Duration : 15ms

Burst Period : 300ms

Inject Line	Voltage kV	Inject Method	Result (Pass/Fail)
L	$\pm 2$	Direct	Pass
N	$\pm 2$	Direct	Pass
PE	$\pm 2$	Direct	Pass
L + N	$\pm 2$	Direct	Pass
L + PE	$\pm 2$	Direct	Pass
N + PE	$\pm 2$	Direct	Pass
L + N + PE	$\pm 2$	Direct	Pass

**Performance & Result:**

- ☒ **Criterion A:** The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
- ☐ **Criterion B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- ☐ **Criterion C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

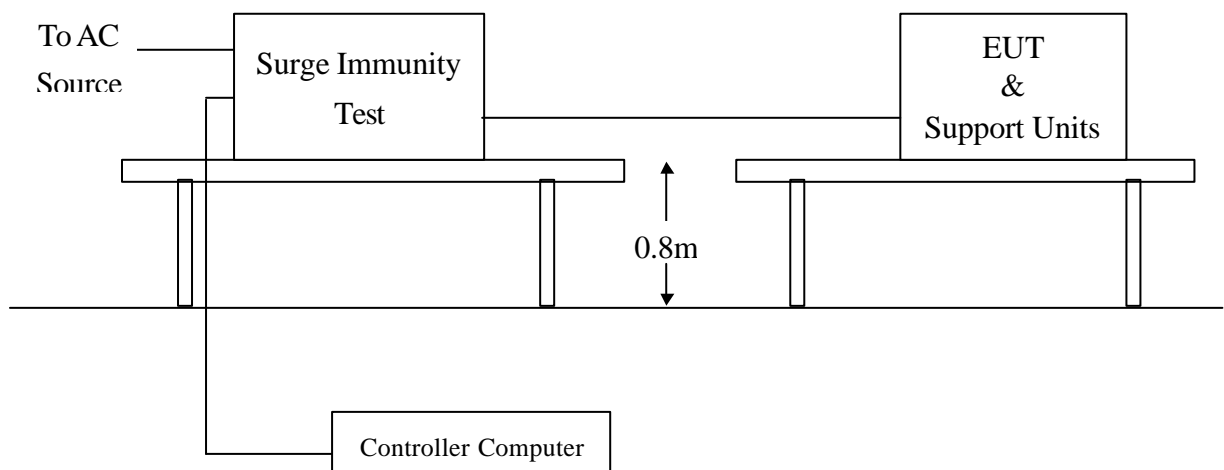
☒ **PASS**      ☐ **FAIL****Observation:** No function degraded during the tests.

## 13 SURGE IMMUNITY TEST

### 13.1 EN 55024

<b>Port</b>	: AC Power Port
<b>Basic Standard</b>	: IEC/EN 61000-4-5
<b>Requirements</b>	: $\pm 1$ kV (Line to Line) for AC Power Port $\pm 2$ kV (Line to Ground) for AC Power Port
<b>Performance Criteria</b>	: B (Standard Required)
<b>Tested by</b>	: Mark Hsu
<b>Temperature</b>	: 19°C
<b>Humidity</b>	: 50%
<b>Pressure</b>	: 1010mbar

#### **Block Diagram of Test Setup:**



#### **Test Procedure:**

1. The EUT and support units were located on a wooden table 0.8 m away from ground floor.
2. Injected test voltage to the EUT ports from minimum to standard request or client request.
3. Recorded the test result as shown in following table.

**Test conditions:**

Voltage Waveform : 1.2/50 *us*  
Current Waveform : 8/20 *us*  
Polarity : Positive/Negative  
Phase angle : 0°, 90°, 180°, 270°  
Number of Test : 5

Coupling Line	Voltage (kV)	Polarity	Coupling Method	Result (Pass/Fail)
L1-L2	1	Positive	Capacitive	Pass
L1-PE	2	Positive	Capacitive	Pass
L2-PE	2	Positive	Capacitive	Pass
L1-L2	1	Negative	Capacitive	Pass
L1-PE	2	Negative	Capacitive	Pass
L2-PE	2	Negative	Capacitive	Pass

**Performance & Result:**

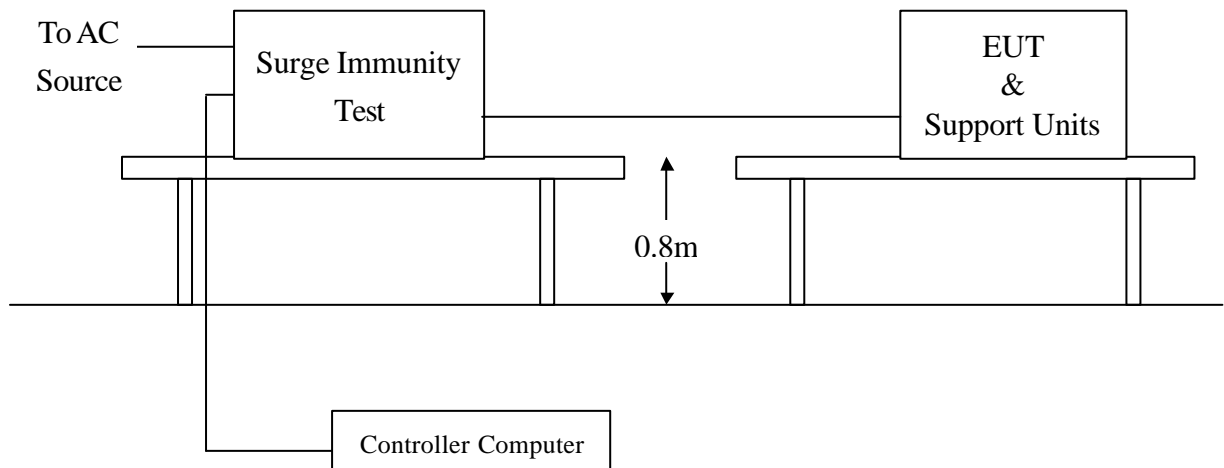
- ☒ **Criterion A:** The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
- ☐ **Criterion B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- ☐ **Criterion C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

**PASS****FAIL**

**Observation:** No function degraded during the tests.

**13.2 EN 61000-6-2**

<b>Port</b>	: AC Power Port
<b>Basic Standard</b>	: IEC/EN 61000-4-5
<b>Requirements</b>	: $\pm 1$ kV (Line to Line) for AC Power Port $\pm 2$ kV (Line to Ground) for AC Power Port
<b>Performance Criteria</b>	: B (Standard Required)
<b>Tested by</b>	: Mark Hsu
<b>Temperature</b>	: 19°C
<b>Humidity</b>	: 50%
<b>Pressure</b>	: 1010mbar

**Block Diagram of Test Setup:****Test Procedure:**

1. The EUT and support units were located on a wooden table 0.8 m away from ground floor.
2. Injected test voltage to the EUT ports from minimum to standard request or client request.
3. Recorded the test result as shown in following table.

**Test conditions :**

Voltage Waveform : 1.2/50 *us*  
Current Waveform : 8/20 *us*  
Polarity : Positive/Negative  
Phase angle : 0°, 90°, 180°, 270°  
Number of Test : 5

Coupling Line	Voltage (kV)	Polarity	Coupling Method	Result (Pass/Fail)
L1-L2	1	Positive	Capacitive	Pass
L1-PE	2	Positive	Capacitive	Pass
L2-PE	2	Positive	Capacitive	Pass
L1-L2	1	Negative	Capacitive	Pass
L1-PE	2	Negative	Capacitive	Pass
L2-PE	2	Negative	Capacitive	Pass

**Performance & Result:**

- ☒ **Criterion A:** The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
- ☐ **Criterion B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- ☐ **Criterion C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

**PASS****FAIL**

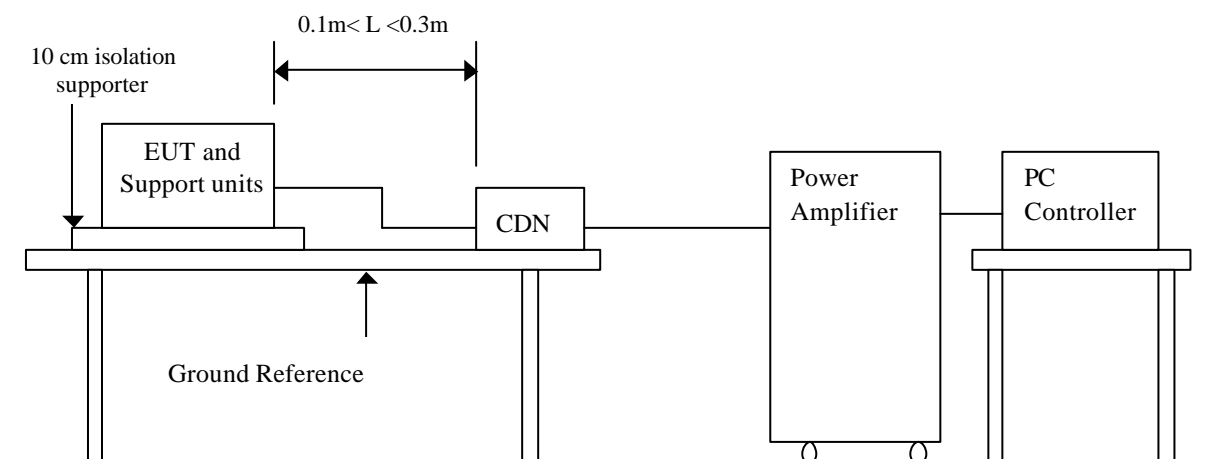
**Observation:** No function degraded during the tests.

## 14 CONDUCTED DISTURBANCE/INDUCED RADIO-FREQUENCY FIELD IMMUNITY TEST

### 14.1 EN 55024

Port	: AC Power Port
Basic Standard	: IEC/EN 61000-4-6
Requirements	: 3V, with 80% AM. 1kHz Modulation.
Injection Method	: CDN-M3 for AC Power Port
Performance Criterion	: A (Standard Required)
Tested by	: Jeffery Chu
Temperature	: 21°C
Humidity	: 50%
Pressure	: 1010mbar

### Block Diagram of Test Setup:



### Test Procedure:

1. The EUT and support units were located at a ground reference plane with the interposition of a 0.1 m thickness insulating support and the CDN was located on GRP directly.
2. Set the testing parameters of CS test software as per IEC/EN 61000-4-6.
3. Recorded the test result in following table.



**Test conditions:**

Frequency Range : 0.15MHz-80MHz

Frequency Step : 1% of fundamental

Dwell Time : 3 sec

Range (MHz)	Field	Modulation	Result (Pass/Fail)
0.15-80	3V	Yes	Pass

**Performance & Result:**

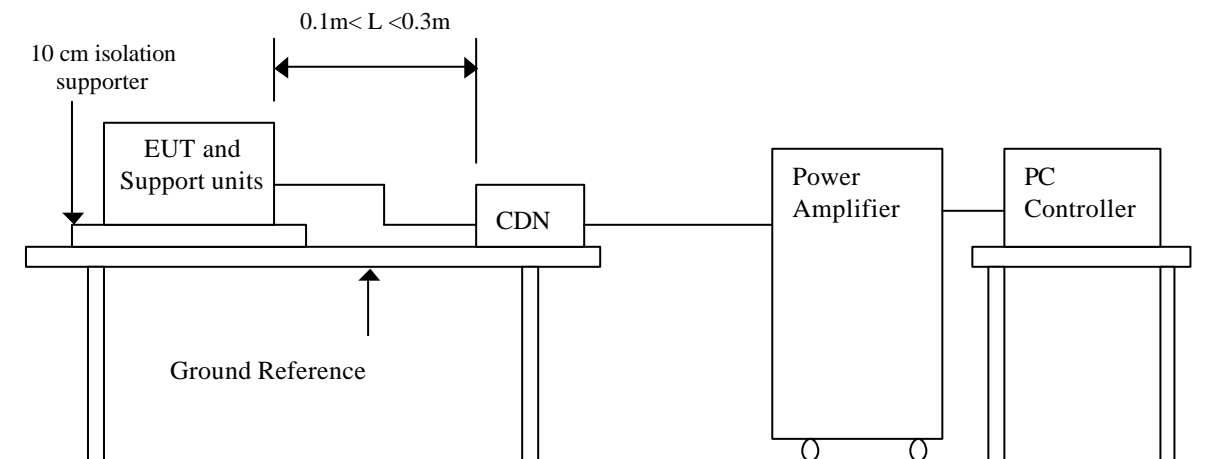
- ☒ **Criterion A:** The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
- ☐ **Criterion B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- ☐ **Criterion C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

☒ **PASS**      ☐ **FAIL****Observation:** No function degraded during the tests.

## 14.2 EN 61000-6-2

<b>Port</b>	: AC Power Port
<b>Basic Standard</b>	: IEC/EN 61000-4-6
<b>Requirements</b>	: 10V, with 80% AM. 1kHz Modulation.
<b>Injection Method</b>	: CDN-M3 for AC Power Port
<b>Performance Criterion</b>	: A (Standard Required)
<b>Tested by</b>	: Jeffery Chu
<b>Temperature</b>	: 22°C
<b>Humidity</b>	: 50%
<b>Pressure</b>	: 1011 mbar

### Block Diagram of Test Setup:



### Test Procedure:

1. The EUT and support units were located at a ground reference plane with the interposition of a 0.1 m thickness insulating support and the CDN was located on GRP directly.
2. Set the testing parameters of CS test software as per IEC/EN 61000-4-6.
3. Recorded the test result in following table.

**Test conditions:**

Frequency Range : 0.15MHz-80MHz

Frequency Step : 1% of fundamental

Dwell Time : 3 sec

Range (MHz)	Field	Modulation	Result (Pass/Fail)
0.15-80	10V	Yes	Pass

**Performance & Result:**

☒ **Criterion A:** The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.

☐ **Criterion B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.

☐ **Criterion C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

☒ **PASS**      ☐ **FAIL**

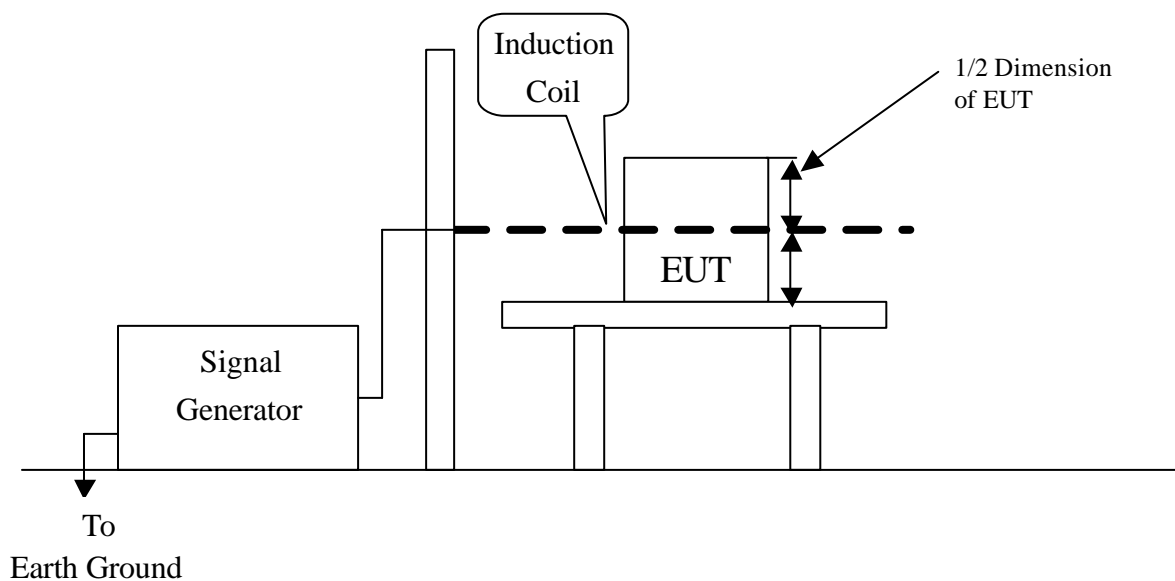
**Observation:** No function degraded during the tests.

## 15 POWER FREQUENCY MAGNETIC FIELD IMMUNITY TEST

### 15.1 EN 55024

<b>Port</b>	: Enclosure
<b>Basic Standard</b>	: IEC/EN 61000-4-8
<b>Requirements</b>	: 1 A/m
<b>Performance Criterion</b>	: A (Standard Required)
<b>Tested by</b>	: N/A
<b>Temperature</b>	: N/A
<b>Humidity</b>	: N/A
<b>Pressure</b>	: N/A

#### Block Diagram of Test Setup:



#### Test Procedure:

1. The EUT and support units were located on Ground Reference Plane with the interposition of a 0.1 m thickness insulation support.
2. Put the induction coil on horizontal direction. ( X direction )
3. Recorded the test result as shown in following table.
4. Rotated the induction coil by 90° ( Y direction ) then repeat step 3.
5. Rotated the induction coil by 90° ( Z direction ) then repeat step 3.

**Test conditions:**

Field Strength: 1A/m  
Power Freq.: 50Hz  
Orientation: X, Y, Z

Orientation	Field	Result (Pass/Fail)	Remark

**Performance & Result:**

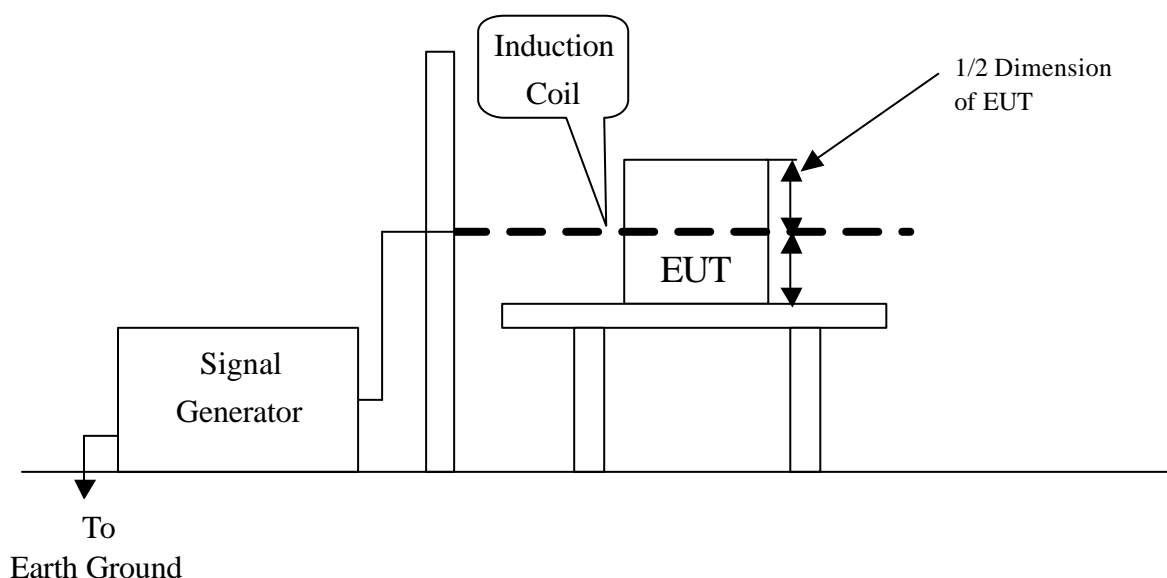
- ☐ **Criterion A:** The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
- ☐ **Criterion B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- ☐ **Criterion C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

☐ **PASS**      ☐ **FAIL**

**Observation:** The EUT is not containing any component that is susceptible to a 50 Hz or 60 Hz magnetic field. Therefore, this requirement is not applicable to the EUT.

**15.2 EN 61000-6-2**

**Port** : Enclosure  
**Basic Standard** : IEC/EN 61000-4-8  
**Requirements** : 30 A/m  
**Performance Criterion** : A (Standard Required)  
**Tested by** : Mark Hsu  
**Temperature** : 21°C  
**Humidity** : 50%  
**Pressure** : 1010mbar

**Block Diagram of Test Setup:****Test Procedure:**

1. The EUT and support units were located on Ground Reference Plane with the interposition of a 0.1 m thickness insulation support.
2. Put the induction coil on horizontal direction. ( X direction )
3. Recorded the test result as shown in following table.
4. Rotated the induction coil by 90° ( Y direction ) then repeat step 3.
5. Rotated the induction coil by 90° ( Z direction ) then repeat step 3.

**Test conditions:**

Field Strength: 30A/m  
Power Freq.: 50Hz, 60Hz  
Orientation: X, Y, Z

Orientation	Field	Result (Pass/Fail)	Remark
X	30A/m, 50Hz	Pass	No function degraded during the tests.
Y	30A/m, 50Hz	Pass	No function degraded during the tests.
Z	30A/m, 50Hz	Pass	No function degraded during the tests.
X	30A/m, 60Hz	Pass	No function degraded during the tests.
Y	30A/m, 60Hz	Pass	No function degraded during the tests.
Z	30A/m, 60Hz	Pass	No function degraded during the tests.

**Performance & Result:**

**Criterion A:** The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.



**Criterion B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.



**Criterion C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

**PASS****FAIL**

**Observation:** No function degraded during the tests.

## 16 VOLTAGE DIPS / SHORT INTERRUPTIONS

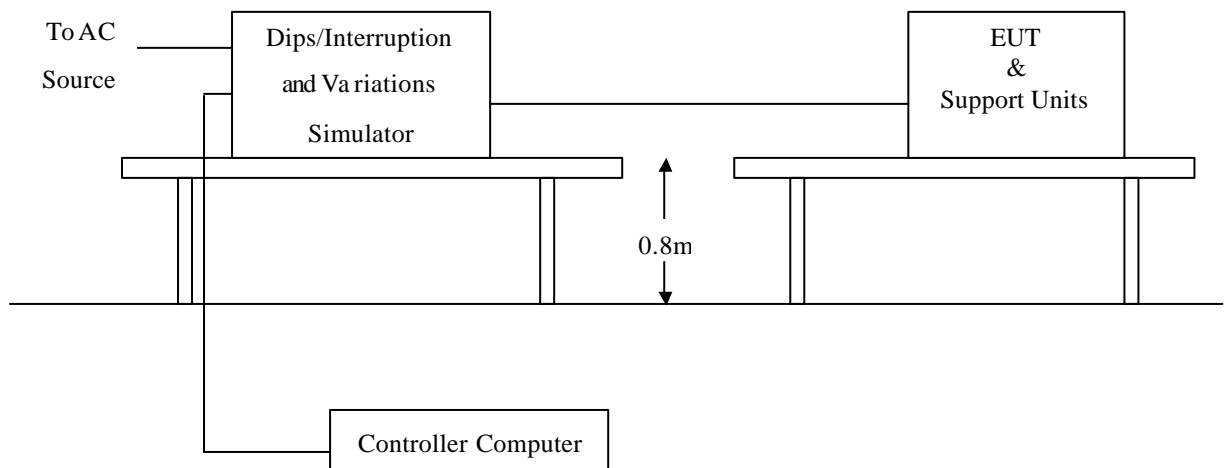
### 16.1 EN 55024

<b>Port</b>	:	AC Power Port
<b>Basic Standard</b>	:	IEC/EN 61000-4-11
<b>Requirement</b>	:	PHASE ANGLE 0, 45, 90, 135, 180, 225, 270, 315 degrees
<b>Test Interval</b>	:	Min. 10 sec.
<b>Tested by</b>	:	Mark Hsu
<b>Temperature</b>	:	19°C
<b>Humidity</b>	:	50%
<b>Pressure</b>	:	1010mbar

Voltage Dips	Test Level % U <sub>T</sub>	Reduction (%)	Duration ( periods )	Performance Criterion
	<5	>95	0.5	B
	70	30	25	C

Voltage Interruptions	Test Level % U <sub>T</sub>	Reduction (%)	Duration ( periods )	Performance Criterion
	<5	>95	250	C

### Block Diagram of Test Setup:



### Test Procedure:

1. The EUT and support units were located on a wooden table, 0.8 m away from ground floor.
2. Set the parameter of tests and then Performed the test software of test simulator.
3. Changed Condition to occur at 0 degree crossover point of the voltage waveform.
4. Recorded the test result in test record form.



**Test conditions:**

The duration with a sequence of three dips/interruptions with interval of 10 sec. minimum  
(Between each test event )

**Voltage Dips:**

Test Level % U <sub>T</sub>	Reduction (%)	Duration (periods)	Observation	Meet Performance Criterion
0	100	0.5	Normal	A
70	30	25	Normal	A

**Voltage Interruptions:**

Test Level % U <sub>T</sub>	Reduction (%)	Duration (periods)	Observation	Meet Performance Criterion
0	100	250	EUT shut down, but EUT can be auto recovered after it restart.	C

**Note:** "Normal" means no any functions degrade during and after the test.

**Performance & Result:**

**Criterion A:** The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.

**Criterion B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.

**Criterion C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

☒ **PASS**      ☐ **FAIL**

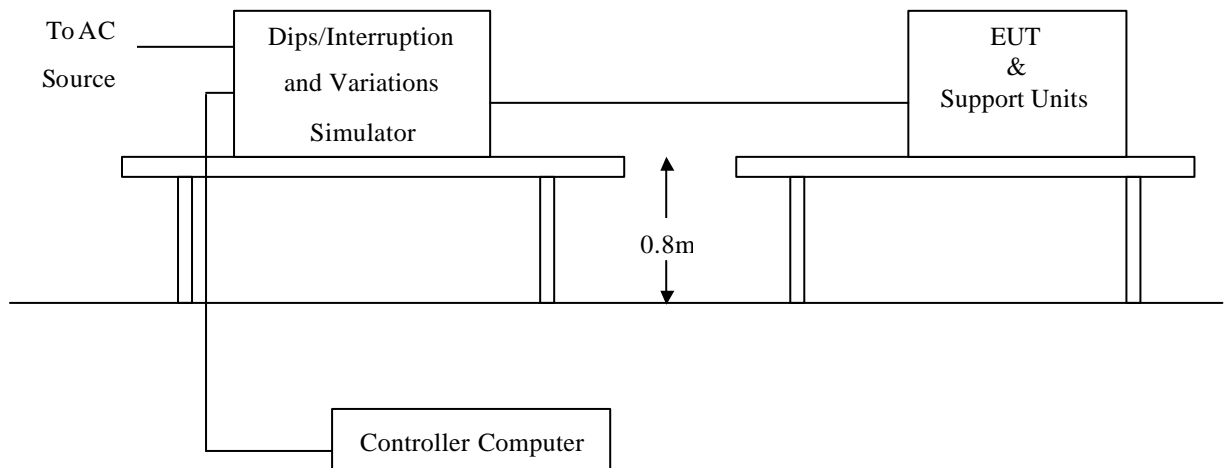
**Observation:** No function degraded during the tests.

## 16.2 EN 61000-6-2

**Port** : AC Power Port  
**Basic Standard** : IEC/EN 61000-4-11  
**Requirement** : PHASE ANGLE 0, 45, 90, 135, 180, 225, 270, 315 degrees  
**Test Interval** : Min. 10 sec.  
**Tested by** : Mark Hsu  
**Temperature** : 19°C  
**Humidity** : 50%  
**Pressure** : 1010mbar

Test Level % U <sub>T</sub>	Reduction (%)	Duration (Periods)	Performance Criteria
70	30	0.5	B
40	60	5	B
40	60	50	C
< 5	> 95	250	C

### Block Diagram of Test Setup:



### Test Procedure:

1. The EUT and support units were located on a wooden table, 0.8 m away from ground floor.
2. Set the parameter of tests and then Performed the test software of test simulator.
3. Changed Condition to occur at 0 degree crossover point of the voltage waveform.
4. Recorded the test result in test record form.

**Test conditions:**

The duration with a sequence of three dips/interruptions with interval of 10 s minimum  
(Between each test event )

Test Level % U <sub>T</sub>	Reduction (%)	Duration (periods)	Observation	Meet Performance Criteria
70	30	0.5	Normal	A
40	60	5	Normal	A
40	60	50	Normal	A
< 5	> 95	250	EUT shut down, but can be auto recovered as the events disappear.	C

*Normal: No any functions degrade during and after the test.*

**Performance & Result:**

**Criterion A:** The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.

**Criterion B:** The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.

**Criterion C:** Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

☒ **PASS**      ☐ **FAIL**

**Observation:** No function degraded during the tests.

## APPENDIX I - PHOTOGRAPHS OF TEST SETUP

### CONDUCTED EMISSION TEST (EN 55022 / EN 55011)



## RADIATED EMISSION TEST (EN 55022)





## **RADIATED EMISSION TEST (EN 55011)**



## POWER HARMONIC & VOLTAGE FLUCTUATION / FLICKER TEST



## ELECTROSTATIC DISCHARGE TEST



## RADIATED ELECTROMAGNETIC FIELD TEST



## FAST TRANSIENTS/BURST TEST





## **SURGE IMMUNITY TEST**



## **CONDUCTED DISTURBANCE, INDUCED BY RADIO-FREQUENCY FIELDS TEST**



## POWER FREQUENCY MAGNETIC FIELD IMMUNITY TEST



## VOLTAGE DIPS / INTERRUPTION TEST



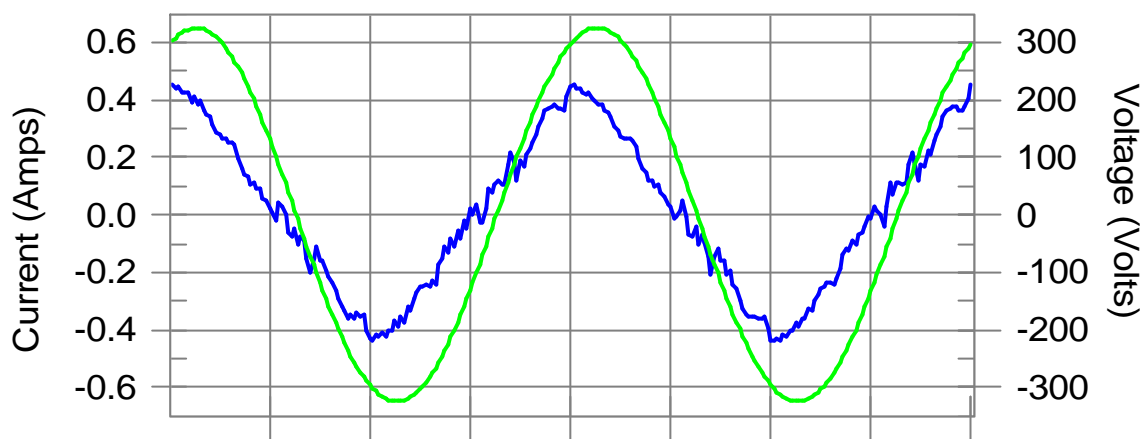


## APPENDIX II – TEST RESULT OF EN 61000-3-2/-3

Test Result: Pass

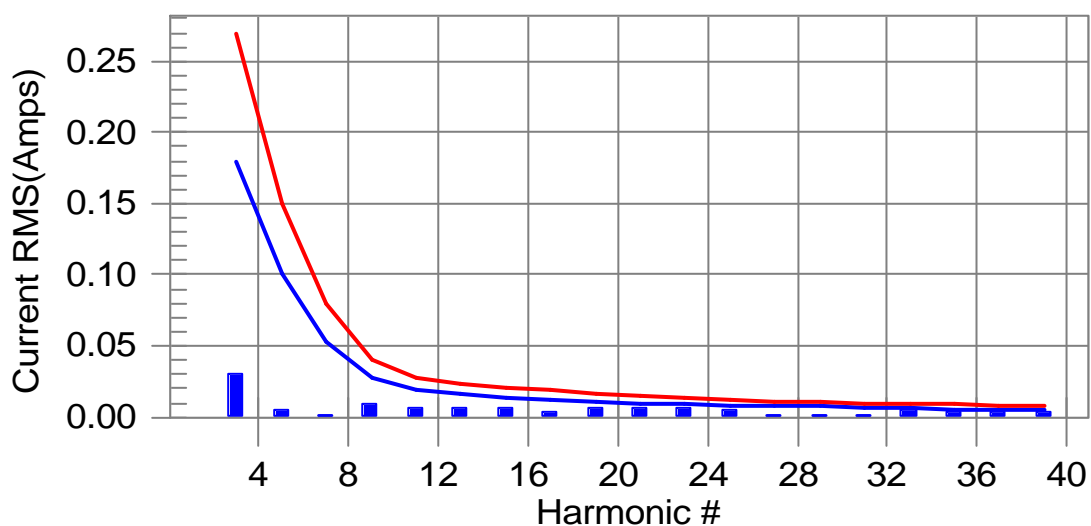
Source qualification: Normal

### Current & voltage waveforms



### Harmonics and Class D limit line

### European Limits



Test result: Pass

Worst harmonic was #23 with 52.80 % of the limit.



Test Result: Pass

Source qualification: Normal

THC(A): 0.037

I<sub>THD</sub>(pk%): 14.753

POHC(A): N/A

POHC Limit(A): N/A

Highest parameter values during test:

V<sub>RMS</sub> (Volts): 229.93I<sub>Peak</sub> (Amps): 0.457I<sub>Fund</sub> (Amps): 0.267

Power (Watts): 58

I<sub>RMS</sub> (Amps): 0.267

Crest Factor: 1.788

Power Factor: 0.952

Harm#	Harms(avg)	100%Limit	%of Limit	Harms(max)	150%Limit	%of Limit	Status
2	0.000						
3	0.030	0.179	16.5	0.030	0.269	11.07	Pass
4	0.000						
5	0.005	0.100	4.7	0.005	0.150	3.37	Pass
6	0.000						
7	0.001	0.053	2.6	0.002	0.079	1.95	Pass
8	0.000						
9	0.008	0.027	32.0	0.009	0.041	22.15	Pass
10	0.000						
11	0.007	0.018	35.5	0.007	0.028	24.71	Pass
12	0.000						
13	0.006	0.016	37.4	0.007	0.024	27.77	Pass
14	0.000						
15	0.007	0.014	51.0	0.007	0.020	35.19	Pass
16	0.000						
17	0.003	0.013	20.9	0.003	0.019	16.34	Pass
18	0.000						
19	0.006	0.011	54.6	0.006	0.016	37.76	Pass
20	0.000						
21	0.006	0.010	59.1	0.006	0.015	41.21	Pass
22	0.000						
23	0.006	0.009	71.7	0.007	0.013	52.80	Pass
24	0.000						
25	0.004	0.008	54.9	0.005	0.012	39.66	Pass
26	0.000						
27	0.001	0.008	15.6	0.001	0.011	11.79	Pass
28	0.000						
29	0.001	0.007	9.6	0.001	0.011	10.40	Pass
30	0.000						
31	0.001	0.007	12.3	0.001	0.010	9.33	Pass
32	0.000						
33	0.004	0.006	71.4	0.005	0.009	48.85	Pass
34	0.000						
35	0.003	0.006	57.7	0.004	0.009	41.12	Pass
36	0.000						
37	0.003	0.005	53.0	0.003	0.008	38.44	Pass
38	0.000						
39	0.003	0.005	57.3	0.003	0.008	39.64	Pass
40	0.000						

**Test Result: Pass****Source qualification: Normal****Highest parameter values during test:**

Voltage (Vrms): 229.93

I\_Peak (Amps): 0.457

I\_Fund (Amps): 0.267

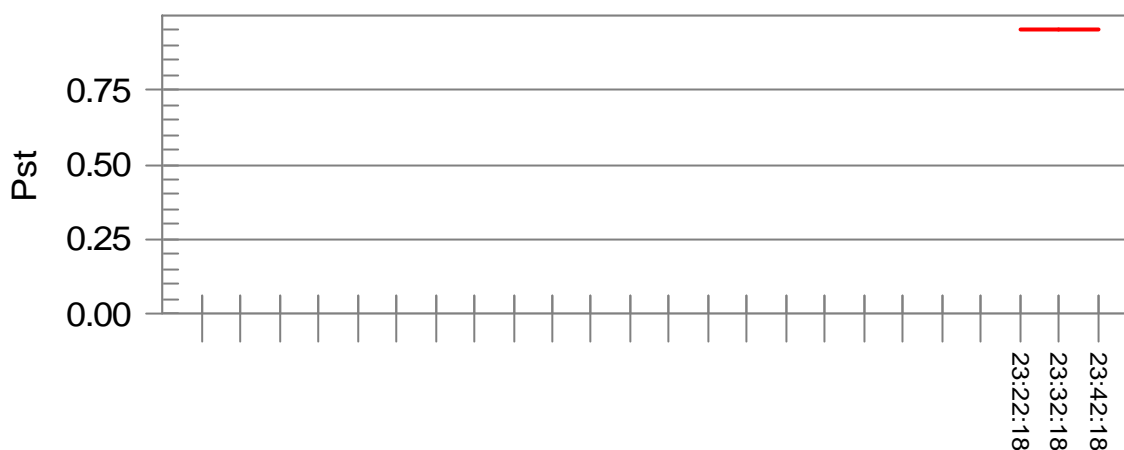
Power (Watts): 58

I\_RMS (Amps): 0.267

Crest Factor: 1.788

Power Factor: 0.952

Harm#	Harmonics V-rms	Limit V-rms	% of Limit	Status
2	0.113	0.460	24.65	OK
3	0.360	2.068	17.41	OK
4	0.039	0.459	8.46	OK
5	0.033	0.920	3.61	OK
6	0.029	0.459	6.42	OK
7	0.031	0.690	4.46	OK
8	0.033	0.460	7.20	OK
9	0.051	0.460	11.00	OK
10	0.012	0.459	2.67	OK
11	0.020	0.230	8.82	OK
12	0.023	0.230	9.85	OK
13	0.031	0.230	13.59	OK
14	0.014	0.230	6.24	OK
15	0.015	0.230	6.46	OK
16	0.013	0.230	5.82	OK
17	0.014	0.230	6.18	OK
18	0.025	0.230	10.96	OK
19	0.021	0.230	9.05	OK
20	0.016	0.230	7.09	OK
21	0.031	0.230	13.54	OK
22	0.015	0.230	6.40	OK
23	0.055	0.230	23.74	OK
24	0.012	0.230	5.10	OK
25	0.030	0.230	13.26	OK
26	0.011	0.230	4.65	OK
27	0.018	0.230	7.74	OK
28	0.013	0.230	5.65	OK
29	0.014	0.230	6.09	OK
30	0.019	0.230	8.10	OK
31	0.008	0.230	3.65	OK
32	0.012	0.230	5.25	OK
33	0.015	0.230	6.61	OK
34	0.009	0.230	3.75	OK
35	0.019	0.230	8.09	OK
36	0.009	0.230	3.92	OK
37	0.016	0.230	7.01	OK
38	0.006	0.230	2.80	OK
39	0.009	0.230	3.80	OK
40	0.009	0.230	3.84	OK

**Test Result: Pass****Status: Test Completed****Pst<sub>i</sub> and limit line****European Limits****Time is too short for Plt plot****Parameter values recorded during the test:**

Vrms at the end of test (Volt):	229.57			
Highest dt (%):	0.00	Test limit (%):	3.14	Pass
Time(mS) > dt:	0.0	Test limit (mS):	500.0	Pass
Highest dc (%):	0.00	Test limit (%):	3.14	Pass
Highest dmax (%):	0.00	Test limit (%):	3.80	Pass
Highest Pst (10 min. period):	0.001	Test limit:	0.950	Pass
Highest Plt (2 hr. period):	0.001	Test limit:	0.617	Pass